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Report No.: HR/2018/C000202
Page: 1 of 27

FCC REPORT

Application No:	HR/2018/C0002
Applicant:	Huawei Technologies Co., Ltd.
Address of Applicant:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Manufacturer:	Huawei Technologies Co., Ltd.
Address of Manufacturer:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Factory:	Huawei Technologies Co., Ltd.
Address of Factory:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Product Name:	Smart Phone
Model No.(EUT):	CLT-L09
Trade Mark:	HUAWEI
FCC ID:	QISCLT-L09
Standards:	47 CFR FCC Part 2 47 CFR FCC Part 24 47 CFR FCC Part 27
Test Method:	FCC KDB 971168 D01 Power Meas License Digital Systems v03 TIA-603-E 2016
Date of Receipt:	2018-12-08
Date of Test:	2018-12-09 to 2018-12-17
Date of Issue:	2018-12-17
Test Result:	PASS *

* In the configuration tested, the EUT detailed in this report complied with the standards specified above.



1 Version

Revision Record				
Version	Chapter	Date	Modifier	Remark
01		2018-12-17		Original

Authorized for issue by:			
Tested By		 (Mike Hu) /Project Engineer	2018-12-17
Checked By		 (David Chen) /Reviewer	2018-12-17
			Date
			Date



The difference between model CLT-L09 and model CLT -L29 is show in the below table:

Model	CLT-L29	CLT-L09
Brand	the same	the same
Frequency	the same	the same
SIM Card	Dual SIM	Single SIM
Hardware Version	the same	the same
Software Version	Different	Different
Dimensions	the same	the same
Appearance	the same	the same
main antenna	the same	the same
BT/Wi-Fi antenna	the same	the same
div antenna	the same	the same

Remark:

According to the difference, We do not test CLT-L09 and all the test were refer to report HR/2018/C000201 of CLT-L29 .

2 Test Summary

2.1 LTE CA_2C

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §24.232	EIRP ≤ 2 W	Section 1 of Appendix B	Pass
Peak-Average Ratio	§2.1046, §24.232	Limit≤13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §24.238	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, §24.238	≤ -13 dBm/1 MHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §24.238	≤ -13 dBm/1 MHz.	Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §24.235	≤ ±2.5 ppm.	Section 8 of Appendix B	Pass

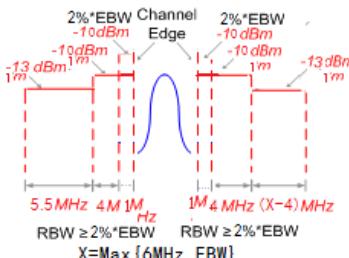
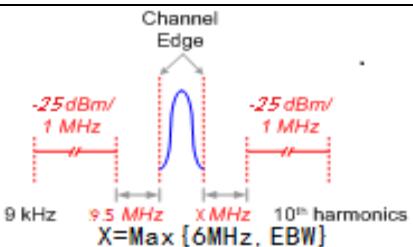
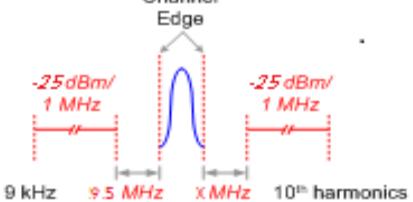
NOTE:For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".

2.2 LTE CA_7C

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(h)	EIRP \leq 2W	Section 1 of Appendix B	Pass
Peak-Average Ratio	§27.50(a)	Limit \leq 13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §27.53(m4)		Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)		Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(m)		Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §27.54	Within authorized bands of operation/frequency block.	Section 8 of Appendix B	Pass

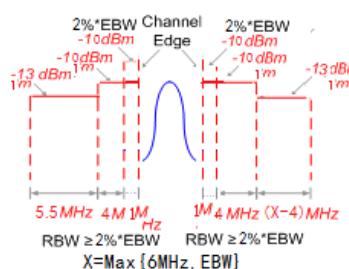
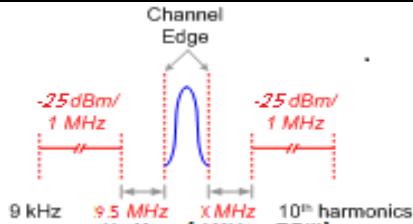
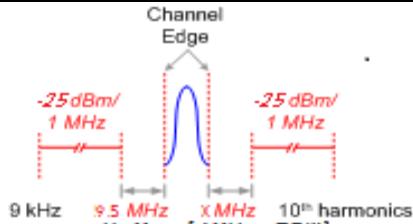
NOTE:For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".

2.3 LTE CA_38C

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(h)	EIRP \leq 2W	Section 1 of Appendix B	Pass
Peak-Average Ratio	§27.50(a)	FCC: Limit \leq 13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §27.53(m)		Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)		Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(m)		Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §27.54	Within authorized bands of operation/frequency block.	Section 8 of Appendix B	Pass

NOTE:For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".

2.4 LTE CA_41C

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(h)	EIRP \leq 2W	Section 1 of Appendix B	Pass
Peak-Average Ratio	§27.50(a)	FCC: Limit \leq 13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §27.53(m)	 <p>2%*EBW Channel Edge -10 dBm -13 dBm 1M Hz 5.5 MHz 4 MHz RBW \geq 2%*EBW X=Max {6MHz, EBW}</p>	Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)	 <p>Channel Edge -25 dBm/ 1 MHz 9 kHz 9.5 MHz X MHz 10th harmonics X=Max {6MHz, EBW}</p>	Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(m)	 <p>Channel Edge -25 dBm/ 1 MHz 9 kHz 9.5 MHz X MHz 10th harmonics X=Max {6MHz, EBW}</p>	Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §27.54	Within authorized bands of operation/frequency block.	Section 8 of Appendix B	Pass

NOTE:For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".

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3 General Information

3.1 Client Information

Applicant:	Huawei Technologies Co., Ltd.
Address of Applicant:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Manufacturer:	Huawei Technologies Co., Ltd.
Address of Manufacturer:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Factory:	Huawei Technologies Co., Ltd.
Address of Factory:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

3.2 Test Location

Company:	SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch
Address:	No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China
Post code:	518057
Telephone:	+86 (0) 755 2601 2053
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E-mail:	ee.shenzhen@sgs.com

3.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• **CNAS (No. CNAS L2929)**

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

• **A2LA (Certificate No. 3816.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

• **VCCI**

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

• **FCC –Designation Number: CN1178**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

• **Industry Canada (IC)**

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

3.4 General Description of EUT

Product Name:	Smart Phone
Model No.:	CLT-L09
Trade Mark:	HUAWEI
Hardware Version:	HL1CLTM
Software Version:	CLT-L09 8.1.0.178(C900)
Sample Type:	<input checked="" type="checkbox"/> Portable Device, <input type="checkbox"/> Module
Antenna Type:	<input type="checkbox"/> External, <input checked="" type="checkbox"/> Integrated
Antenna Gain:	LTE CA_2C: -0.39 dBi(Main Antenna); -1.57 dBi(Secondary Antenna) LTE CA_7C: 1.58 dBi(Main Antenna); -2.52 dBi(Secondary Antenna) LTE CA_38C: 1.96 dBi(Main Antenna); -3.46 dBi(Secondary Antenna) LTE CA_41C: 1.20 dBi(Main Antenna); -1.70 dBi(Secondary Antenna)

3.5 Test Mode

Test Mode	Test Modes Description
LTE/TM1	LTE system, QPSK modulation
LTE/TM2	LTE system, 16QAM modulation
LTE/TM3	LTE system, 64QAM modulation

3.6 Test Environment

Environment Parameter	Selected Values During Tests	
Relative Humidity	52%	
Atmospheric Pressure:	101.3KPa	
Temperature	TN	25 °C
Voltage :	VL	3.6V
	VN	3.82V
	VH	4.35V

NOTE: VL= lower extreme test voltage

VN= nominal voltage

VH= upper extreme test voltage

TN= normal temperature

3.7 Test Frequency

3.7.1

Table 4.3.1.1.2A-2: Test frequencies for CA_2C

Range	CC-Combo / NRB_agg [RB]	CC1 Note1					CC2 Note1				
		BW [RB]	N _{UL}	f _{UL} [MHz]	N _{DL}	f _{DL} [MHz]	BW [RB]	N _{UL}	f _{UL} [MHz]	N _{DL}	f _{DL} [MHz]
Low	25+100	25	18633	1853.3	633	1933.3	100	18750	1865	750	1945
		100	18700	1860	700	1940	25	18817	1871.7	817	1951.7
	50+75	50	18653	1855.3	653	1935.3	75	18773	1867.3	773	1947.3
		75	18675	1857.5	675	1937.5	50	18795	1869.5	795	1949.5
	50+100	50	18655	1855.5	655	1935.5	100	18799	1869.9	799	1949.9
		100	18700	1860	700	1940	50	18844	1874.4	844	1954.4
	75+75	75	18675	1857.5	675	1937.5	75	18825	1872.5	825	1952.5
	75+100	75	18678	1857.8	678	1937.8	100	18849	1874.9	849	1954.9
		100	18700	1860	700	1940	75	18871	1877.1	871	1957.1
	100+100	100	18700	1860	700	1940	100	18898	1879.8	898	1959.8
Mid	25+100	25	18808	1870.8	808	1950.8	100	18925	1882.5	925	1962.5
		100	18875	1877.5	875	1957.5	25	18992	1889.2	992	1969.2
	50+75	50	18829	1872.9	829	1952.9	75	18949	1884.9	949	1964.9
		75	18851	1875.1	851	1955.1	50	18971	1887.1	971	1967.1
	50+100	50	18806	1870.6	806	1950.6	100	18950	1885	950	1965
		100	18851	1875.1	851	1955.1	50	18995	1889.5	995	1969.5
	75+75	75	18825	1872.5	825	1952.5	75	18975	1887.5	975	1967.5
	75+100	75	18803	1870.3	803	1950.3	100	18974	1887.4	974	1967.4
		100	18826	1872.6	826	1952.6	75	18997	1889.7	997	1969.7
	100+100	100	18801	1870.1	801	1950.1	100	18999	1889.9	999	1969.9
High	25+100	25	18983	1888.3	983	1968.3	100	19100	1900	1100	1980
		100	19050	1895	1050	1975	25	19167	1906.7	1167	1986.7
	50+75	50	19005	1890.5	1005	1970.5	75	19125	1902.5	1125	1982.5
		75	19027	1892.7	1027	1972.7	50	19147	1904.7	1147	1984.7
	50+100	50	18956	1885.6	956	1965.6	100	19100	1900	1100	1980
		100	19001	1890.1	1001	1970.1	50	19145	1904.5	1145	1984.5
	75+75	75	18975	1887.5	975	1967.5	75	19125	1902.5	1125	1982.5
	75+100	75	18929	1882.9	929	1962.9	100	19100	1900	1100	1980
		100	18951	1885.1	951	1965.1	75	19122	1902.2	1122	1982.2
	100+100	100	18902	1880.2	902	1960.2	100	19100	1900	1100	1980

Note 1: Carriers in increasing frequency order.

3.7.2
Table 4.3.1.1.1A-1: Test frequencies for CA_7C

Range	CC-Combo / NRB_agg [RB]	CC1 Note1					CC2 Note1				
		BW [RB]	N _{UL}	f _{UL} [MHz]	N _{DL}	f _{DL} [MHz]	BW [RB]	N _{UL}	f _{UL} [MHz]	N _{DL}	f _{DL} [MHz]
Low	50+100	50	20805	2505.5	2805	2625.5	100	20949	2519.9	2949	2639.9
		100	20850	2510	2850	2630	50	20994	2524.4	2994	2644.4
	75+75	75	20825	2507.5	2825	2627.5	75	20975	2522.5	2975	2642.5
	75+100	75	20828	2507.8	2828	2627.8	100	20999	2524.9	2999	2644.9
		100	20850	2510	2850	2630	75	21021	2527.1	3021	2647.1
	100+100	100	20850	2510	2850	2630	100	21048	2529.8	3048	2649.8
Mid	50+100	50	21006	2525.6	3006	2645.6	100	21150	2540	3150	2660
		100	21051	2530.1	3051	2650.1	50	21195	2544.5	3195	2664.5
	75+75	75	21025	2527.5	3025	2647.5	75	21175	2542.5	3175	2662.5
	75+100	75	21003	2525.3	3003	2645.3	100	21174	2542.4	3174	2662.4
		100	21026	2527.6	3026	2647.6	75	21197	2544.7	3197	2664.7
	100+100	100	21001	2525.1	3001	2645.1	100	21199	2544.9	3199	2664.9
High	50+100	50	21206	2545.6	3206	2665.6	100	21350	2560	3350	2680
		100	21251	2550.1	3251	2670.1	50	21395	2564.5	3395	2684.5
	75+75	75	21225	2547.5	3225	2667.5	75	21375	2562.5	3375	2682.5
	75+100	75	21179	2542.9	3179	2662.9	100	21350	2560	3350	2680
		100	21201	2545.1	3201	2665.1	75	21372	2562.2	3372	2682.2
	100+100	100	21152	2540.2	3152	2660.2	100	21350	2560	3350	2680

Note 1: Carriers in increasing frequency order.

3.7.3
Table 4.3.1.2.6A-1: Test frequencies for CA_38C

Range	CC-Combo / NRB_agg [RB]	CC1 Note1			CC2 Note1		
		BW [RB]	N _{UL/DL}	f _{UL/DL} [MHz]	BW [RB]	N _{UL/DL}	f _{UL/DL} [MHz]
Low	75+75	75	37825	2577.5	75	37975	2592.5
	100+100	100	37850	2580	100	38048	2599.8
Mid	75+75	75	37925	2587.5	75	38075	2602.5
	100+100	100	37901	2585.1	100	38099	2604.9
High	75+75	75	38025	2597.5	75	38175	2612.5
	100+100	100	37952	2590.2	100	38150	2610

Note 1: Carriers in increasing frequency order.

3.7.4
Table 4.3.1.2.9A-1: Test frequencies for CA_41C

Range	CC-Combo / NRB_agg [RB]	CC1 Note1			CC2 Note1		
		BW [RB]	N _{UL/DL}	f _{UL/DL} [MHz]	BW [RB]	N _{UL/DL}	f _{UL/DL} [MHz]
Low	25+100	25	40165	2547.5	100	40282	2559.2
		100	40240	2555	25	40357	2566.7
	50+100	50	40190	2550	100	40334	2564.4
		100	40240	2555	50	40384	2569.4
	75+75	75	40215	2552.5	75	40365	2567.5
	75+100	75	40215	2552.5	100	40386	2569.6
		100	40240	2555	75	40411	2572.1
Mid	100+100	100	40240	2555	100	40438	2574.8
	25+100	25	40598	2590.8	100	40715	2602.5
		100	40665	2597.5	25	40782	2609.2
	50+100	50	40596	2590.6	100	40740	2565.0
		100	40641	2595.1	50	40785	2609.5
	75+75	75	40615	2592.5	75	40765	2607.5
	75+100	75	40593	2590.3	100	40764	2607.4
		100	40616	2592.6	75	40787	2609.7
High	100+100	100	40591	2590.1	100	40789	2609.9
	25+100	25	41023	2633.3	100	41140	2645
		100	41098	2640.8	25	41215	2652.5
	50+100	50	40996	2630.6	100	41140	2645
		100	41046	2635.6	50	41190	2650
	75+75	75	41015	2632.5	75	41165	2647.5
	75+100	75	40969	2627.9	100	41140	2645
		100	40994	2630.4	75	41165	2647.5
	100+100	100	40942	2625.2	100	41140	2645

Note 1: Carriers in increasing frequency order.

3.8 Technical Specification

Characteristics	Description	
Radio System Type	<input checked="" type="checkbox"/> LTE_CA	
Supported Frequency Range	LTE CA_2C	Transmission (TX): 1850 to 1910 MHz
		Receiving (RX): 1970 to 1990 MHz
	LTE CA_7C	Transmission (TX): 2500 to 2570 MHz
		Receiving (RX): 2620 to 2690 MHz
	LTE CA_38C	Transmission (TX): 2570 to 2620 MHz
		Receiving (RX): 2570 to 2620 MHz
Target TX Output Power	LTE CA_41C	Transmission (TX): 2545 to 2655 MHz
		Receiving (RX): 2545 to 2655 MHz
Supported Channel Bandwidth	LTE CA_2C	<input checked="" type="checkbox"/> 25+100; <input checked="" type="checkbox"/> 50+75; <input checked="" type="checkbox"/> 50+100; <input checked="" type="checkbox"/> 75+75; <input checked="" type="checkbox"/> 75+100, <input checked="" type="checkbox"/> 100+100
	LTE CA_7C	<input checked="" type="checkbox"/> 50+100; <input checked="" type="checkbox"/> 75+50; <input checked="" type="checkbox"/> 75+75, <input checked="" type="checkbox"/> 75+100 <input checked="" type="checkbox"/> 100+100
	LTE CA_38C	<input checked="" type="checkbox"/> 75+75; <input checked="" type="checkbox"/> 100+100;
	LTE CA_41C	<input checked="" type="checkbox"/> 25+100; <input checked="" type="checkbox"/> 50+75; <input checked="" type="checkbox"/> 50+100; <input checked="" type="checkbox"/> 75+75; <input checked="" type="checkbox"/> 75+100, <input checked="" type="checkbox"/> 100+100

Characteristics	Description	
Designation of Emissions (Note: the necessary bandwidth of which is the worst value from the measured occupied bandwidths for each type of channel bandwidth configuration.)	LTE CA_2C	100RB+25RB
		22M9G7D;22M9W7D; 22M9W7D
	LTE CA_7C	100RB+100RB:
		37M6G7D;37M6W7D; 37M6W7D
	LTE CA_38C	75RB+75RB
		28M4G7D;28M4W7D; 28M4W7D
	LTE CA_41C	100RB+100RB
		37M6G7D;37M6W7D; 37M6W7D
	LTE CA_2C	75RB+75RB
		28M3G7D;28M4W7D; 28M3W7D
	LTE CA_38C	100RB+100RB
		37M7G7D;37M6W7D; 37M5W7D
	LTE CA_41C	100RB+25RB
		22M9G7D;22M9W7D; 22M9W7D
	LTE CA_2C	100RB+100RB
		37M6G7D;37M6W7D; 37M6W7D

4 Description of Tests

4.1 Conducted Output Power

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

The transmitter output was connected to a calibrated coaxial cable, attenuator and power meter, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The power output at the transmitter antenna port was determined by adding the value of the cable insertion loss to the power reading. The tests were performed at three frequencies (low channel, middle channel and high channel) and on the highest power levels, which can be setup on the transmitters.

Note: Reference test setup 1

4.2 Effective (Isotropic) Radiated Power of Transmitter

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 1.5m high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.
- 6). The output power into the substitution antenna was then measured.
- 7). Steps 5) and 6) were repeated with both antennas polarized.
- 8). Calculate power in dBm by the following formula:

$$\text{ERP (dBm)} = \text{Pg(dBm)} - \text{cable loss (dB)} + \text{antenna gain (dBd)}$$

Where:

Pg is the generator output power into the substitution antenna.

Above 1GHz test procedure as below:

- 1). Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2). Calculate power in dBm by the following formula:
$$\text{EIRP(dBm)} = \text{Pg(dBm)} - \text{cable loss (dB)} + \text{antenna gain (dBi)}$$

$$\text{EIRP} = \text{ERP} + 2.15 \text{dB}$$

Where:
Pg is the generator output power into the substitution antenna.
- 3). Test the EUT in the lowest channel, the middle channel the Highest channel
- 4). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 5). Repeat above procedures until all frequencies measured was complete.

Note: Reference test setup 2

4.3 Occupied Bandwidth

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel, middle channel and high channel).The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Note: Reference test setup 1

4.4 Band Edge at Antenna Terminals

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel).in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to peak or peak hold power.

Note: Reference test setup 1

4.5 Spurious And Harmonic Emissions at Antenna Terminal

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel).The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least $43 + 10 \log(P)$ dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Note: Reference test setup 1

4.6 Peak-Average Ratio

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Note: Reference test setup 1

4.7 Field Strength of Spurious Radiation

Measurement Procedure: FCC KDB 971168 D01 Power Meas License Digital Systems v03

Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 150cm high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.
- 6). The output power into the substitution antenna was then measured.
- 7). Steps 5) and 6) were repeated with both antennas polarized.
- 8) Calculate power in dBm by the following formula:

$$\text{ERP(dBm)} = \text{Pg(dBm)} - \text{cable loss (dB)} + \text{antenna gain (dBd)}$$

Where:

Pd is the dipole equivalent power, Pg is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB]. The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of $43 + 10\log_{10}(\text{Power [Watts]})$.

Above 1GHz test procedure as below:

- 1) Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2) Calculate power in dBm by the following formula:

$$\begin{aligned}\text{EIRP(dBm)} &= \text{Pg(dBm)} - \text{cable loss (dB)} + \text{antenna gain (dBi)} \\ \text{EIRP} &= \text{ERP} + 2.15\text{dB}\end{aligned}$$

Where:

Pg is the generator output power into the substitution antenna.

3. Test the EUT in the lowest channel, the middle channel the Highest channel
4. The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
5. Repeat above procedures until all frequencies measured was complete

Note: Reference test setup 3

4.8 Frequency Stability / Temperature Variation

Measurement Procedure:

Frequency stability testing is performed in accordance with the guidelines of FCC KDB 971168 D01 Power Meas License Digital Systems v03

. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency.

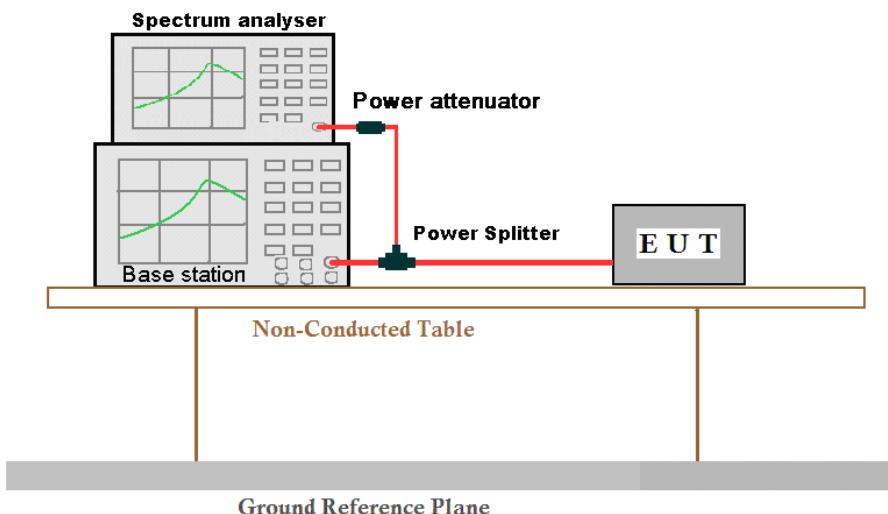
Time Period and Procedure:

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Note: Reference test setup 4

4.9 Test Setups

4.9.1 Test Setup 1



4.9.2 Test Setup 2

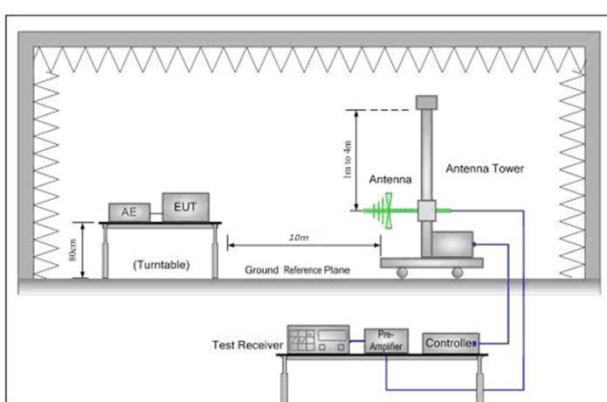


Figure 1. 30MHz to 1GHz

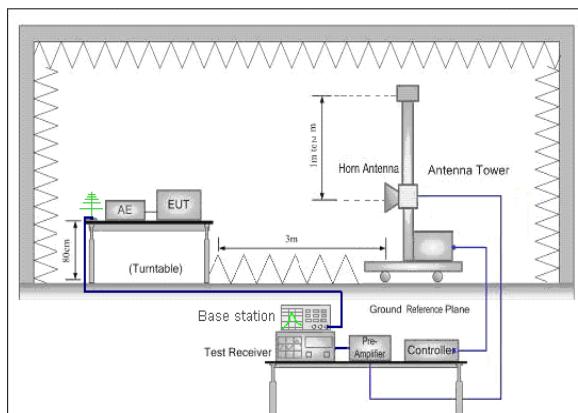


Figure 2. above 1GHz

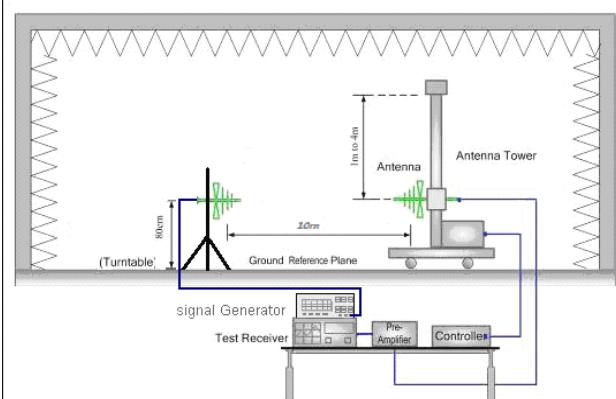


Figure 1. 30MHz to 1GHz

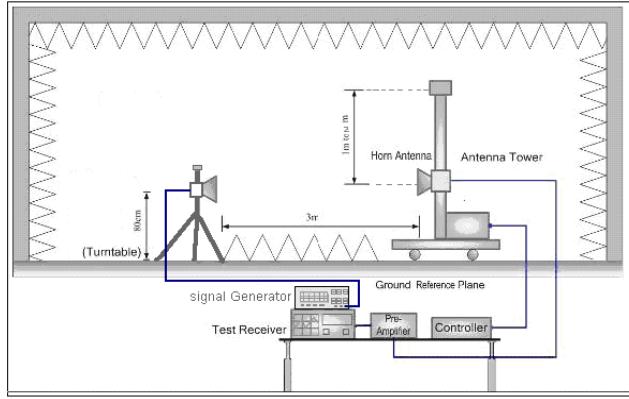


Figure 2. above 1GHz

4.9.3 Test Setup 3

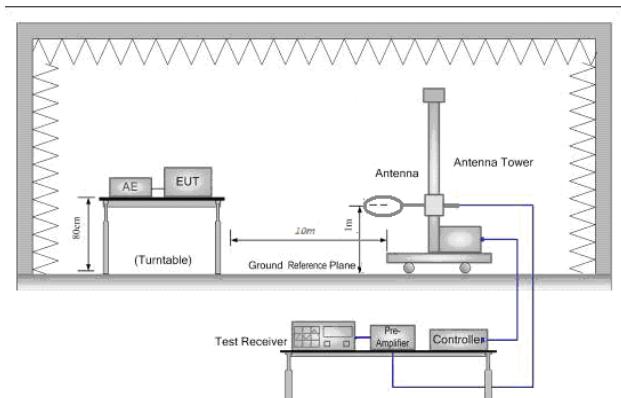


Figure 1. Below 30MHz

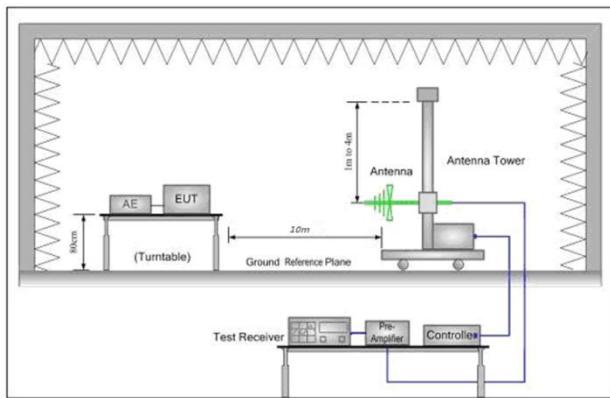


Figure 2. 30MHz to 1GHz

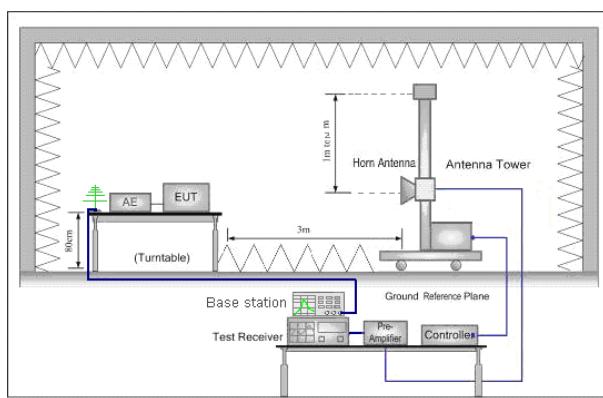


Figure 3. above 1GHz

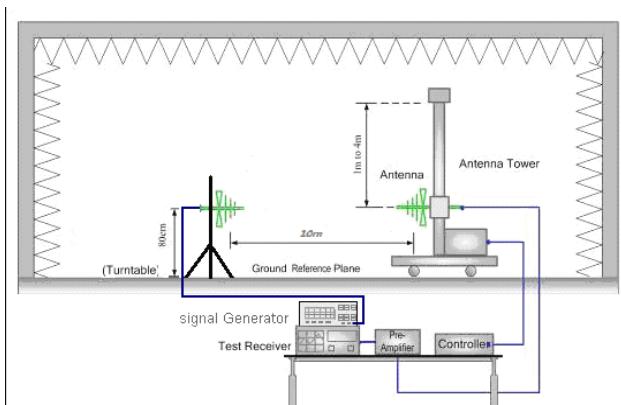


Figure 2. 30MHz to 1GHz

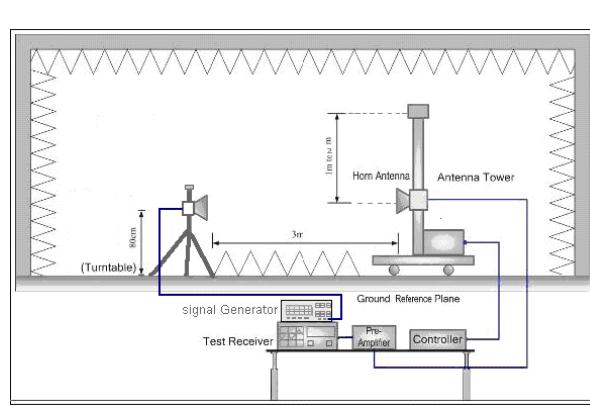
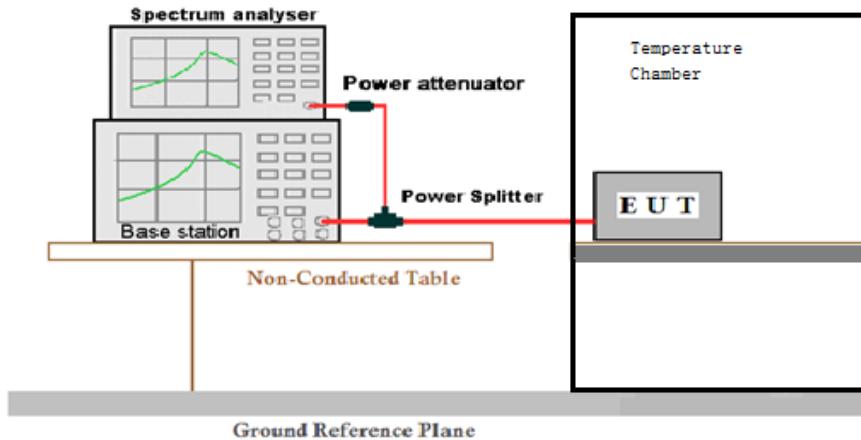


Figure 3. above 1GHz

4.9.4 Test Setup 4

4.10 Test Conditions

Test Case		Test Conditions		
Transmit Output Power Data	Average Power, Total	Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)	
		Test Mode	LTE/TM1; LTE/TM2;LTE/TM3	
	Average Power, Spectral Density (if required)	Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)	
		Test Mode	LTE/TM1; LTE/TM2;LTE/TM3	
Peak-to-Average Ratio (if required)		Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)	
		Test Mode	LTE/TM1; LTE/TM2;LTE/TM3	
Modulation Characteristics		Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	M (M= middle channel)	
		Test Mode	LTE/TM1;LTE/TM2;LTE/TM3	
Bandwidth	Occupied Bandwidth	Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)	
		Test Mode	LTE/TM1; LTE/TM2;LTE/TM3	
	Emission Bandwidth (if required)	Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)	
		Test Mode	LTE/TM1; LTE/TM2;LTE/TM3	
Band Edges Compliance		Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	L, H (L= low channel, H= high channel)	
		Test Mode	LTE/TM1; LTE/TM2;LTE/TM3	
Spurious Emission at Antenna Terminals		Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels (TX)	L,M, H (L= low channel, M= middle channel, H= high channel)	
		Test Mode	LTE/TM1	
Field Strength of Spurious Radiation		Test Environment	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 2	
		Test Mode	LTE/TM1;LTE/TM2; LTE/TM3;NOTE: If applicable, the EUT conf. that has maximum power density (based on the	



		equivalent power level) is selected.
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Frequency Stability	Test Env.	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage; (2) VL, VN and VH of Rated Voltage at Ambient Climate.
	Test Setup	Test Setup 4
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
	Test Mode	LTE/TM1;LTE/TM2; LTE/TM3

5 Main Test Instruments

RE in Chamber					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
3m Semi-Anechoic Chamber	AUDIX	N/A	SEM001-02	2018/3/13	2021/3/12
Spectrum Analyzer (20Hz-43GHz)	Rohde & Schwarz	FSU43	SEM004-08	2018/4/2	2019/4/1
BiConiLog Antenna (26-3000MHz)	ETS-Lindgren	3142C	SEM003-01	2017/6/27	2020/6/26
Horn Antenna (800MHz-18GHz)	Rohde & Schwarz	HF907	SEM003-07	2018/413	2021/412
Horn Antenna (15-40GHz)	Schwarzbeck	BBHA 9170	SEM003-15	2017/10/17	2020/10/16
Amplifier (0.1-1300MHz)	HP	8447D	SEM005-02	2018/9/2	2019/9/2
Low Noise Amplifier (100MHz-18GHz)	Black Diamond Series	BDLNA-0118-352810	SEM005-05	2018/9/2	2019/9/2
Pre-Amplifier (0.1-26.5GHz)	Compliance Directions Systems Inc.	PAP-0126	EMC2063	2018/10/20	2019/10/19
Pre-amplifier (26-40GHz)	Compliance Directions Systems Inc.	PAP-2640-50	SEM005-08	2018/4/2	2019/4/1
Band filter	N/A	N/A	N/A	N/A	N/A
Measurement Software	AUDIX	e3 V8.2014-6-27	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM026-01	2018/7/12	2019/7/11
Wideband Radio Communication Tester	Anristu	MT8821C	6201462742	2018/5/2	2019/5/1
Wideband Radio Communication Tester	Rohde & Schwarz	CMW500	W005-02	2018/3/13	2019/3/12

RF conducted test					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
Dual Output Mobile Communication DC Source	Agilent Technologies Inc	66311B	W009-09	2018/9/15	2019/9/15
Signal Analyzer	Rohde & Schwarz	FSV	W025-05	2018/3/13	2019/3/12
Coaxial Cable	SGS	N/A	SEM031-01	2018/7/12	2019/7/11
Attenuator	Weinschel Associates	WA41	SEM021-09	N/A	N/A
Signal Generator	KEYSIGHT	N5173B	SEM006-05	2018/9/2	2019/9/2
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	HTC-1	W006-17	2018/9/10	2019/9/10
Temperature Chamber	GIANT FORCE	ICT-150-40-CP-AR	W027-03	2018/11/27	2019/11/27
Wideband Radio Communication Tester	Anristu	MT8821C	6201462742	2018/5/2	2019/5/1



Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. Date (yyyy-mm-dd)	Cal. Due date (yyyy-mm-dd)
3m Semi-Anechoic Chamber	AUDIX	N/A	SEM001-02	2018/3/13	2021/3/12
Wideband Radio Communication Teste	Anristu	MT8821C	6.201E+09	2018/5/2	2019/5/1
Wideband Radio Communication Tester	Rohde & Schwarz	CMW500	W005-02	2018/3/13	2019/3/12
EXA Signal Analyzer (10Hz-26.5GHz)	Agilent Technologies Inc	N9010A	SEM004-09	2018/4/13	2019/4/12
Spectrum Analyzer (20Hz-43GHz)	Rohde & Schwarz	FSU43	SEM004-08	2018/4/2	2019/4/1
BiConiLog Antenna (26-3000MHz)	ETS-Lindgren	3142C	SEM003-01	2017/6/27	2020/6/26
Horn Antenna (800MHz-18GHz)	Rohde & Schwarz	HF907	SEM003-07	2018/4/13	2021/4/12
Horn Antenna (15-40GHz)	Schwarzbeck	BBHA 9170	SEM003-15	2017/10/17	2020/10/16
Amplifier (0.1-1300MHz)	HP	8447D	SEM005-02	2018/9/25	2019/9/24
Pre-Amplifier (0.1-26.5GHz)	Compliance Directions Systems Inc.	PAP-0126	SEM004-11	2018/9/27	2019/9/26
Pre-amplifier (26-40GHz)	Compliance Directions Systems Inc.	PAP-2640-50	SEM005-08	2018/4/2	2019/4/1
Band filter	N/A	N/A	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM026-01	2018/7/12	2019/7/11
Tunable Notch Filter WRCD1700/2000-0.2/40-10EEK	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
Tunable Notch Filter WRCD800/960-0.2/40-10EEK	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
HighPass Filter WHK1.2/15G-10SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
HighPass Filter WHKX10-2700-3000-18000-40SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
HighPass Filter WHKX7.0/26.5G-6SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
Band Reject Filter WRCG 824/849-814/859-40/8SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
Band Reject Filter WRCG 1850/1910-1835/1925-40/8SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
Measurement Software	AUDIX	e3 V8.2014-6-27	N/A	N/A	N/A

6 Measurement Uncertainty

For a 95% confidence level ($k = 2$), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item	Extended Uncertainty	Data
Transmit Output Power Data	Power [dBm]	$U = \pm 0.37 \text{ dB}$
Bandwidth	Magnitude [%]	$U = \pm 0.2\%$
Band Edge Compliance	Disturbance Power [dBm]	$U = \pm 2.0 \text{ dB}$
Spurious Emissions, Conducted	Disturbance Power [dBm]	$U = \pm 2.0 \text{ dB}$
Field Strength of Spurious Radiation	ERP [dBm]	For 3 m Chamber: $U = \pm 4.5 \text{ dB}$ (30 MHz to 1GHz) $U = \pm 3.3 \text{ dB}$ (above 1 GHz) For 10 m Chamber: $U = \pm 4.5 \text{ dB}$ (30 MHz to 1GHz) $U = \pm 3.2 \text{ dB}$ (above 1 GHz)
Frequency Stability	Frequency Accuracy [ppm]	$U = \pm 0.24 \text{ ppm}$

7 Photographs - EUT Constructional Details

Refer to Appendix A - Photographs of EUT Constructional Details for HR/2018/C0002.

The End